Applicant(s)/Patent Under Application/Control No. Reexamination 10/591,104 OFUJI ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 CHRISTOPHER E. VERAA 3611 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-6,466,369 10-2002 Maddock, Alan 359/460 * US-2006/0209406 09-2006 Choi, Hae-Yong 359/461 В US-С US-D US-Ε F US-US-G US-Н US-1 US-US-Κ US-US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Classification Name Country Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

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